

Search Notes

Application/Control No.

10/053,785

Examiner

Robert R. Koehler

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

1775

SEARCHED

Class	Subclass	Date	Examiner
205	224, 227 255	4/18/2005	RRK. RRK.
148	108, 121		
148	518, 529	4/18/2005	RRK. RRK.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
205	224, 227	4/18/2005	RRK. RRK.
205	255		
148	108, 121		
148/518, 529		4/18/2005	RRK. RRK.

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

RRK.	DATE	EXMR